Rochester Electronics

Datasheet

PART NUMBER

54L164DMB-ROCV

Rochester Electronics Manufactured Components

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All re-creations are done with the approval of the Original Component Manufacturer. (OCM)

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceeds the OCM data sheet.

Quality Overview

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-38535
    - Class Q Military
    - Class V Space Level

Qualified Suppliers List of Distributors (QSLD)

- Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OCM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.

Rochester Electronics®

Datasheet

54L164

8-Bit Parallel-Out Serial Shift Registers

These 8-bit shift registers feature gated serial inputs and an asynchronous clear. The gated serial inputs (A and B) permit complete control over incoming data as a low at either input inhibits entry of the new data and resets the first flip-flop to the low level at the next clock pulse. A high-level input enables the other input which will then determine the state of the first flip-flop. Data at the serial inputs may be changed while the clock is high or low, but only information meeting the setup-time requirements will be entered. Clocking occurs on the low-to-high-level transition of the clock input. All inputs are diode-clamped to minimize transmission-line effects.

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FOR REFERENCE ONLY

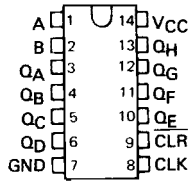
TYPES SN54164, SN54L164, SN54LS164, SN74164, SN74LS164
8-BIT PARALLEL-OUT SERIAL SHIFT REGISTERS

MARCH 1974—REVISED DECEMBER 1983

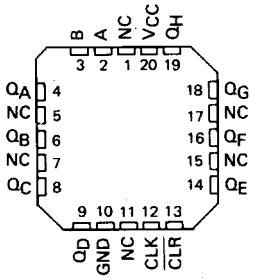
- **Gated Serial Inputs**
- **Fully Buffered Clock and Serial Inputs**
- **Asynchronous Clear**

TYPE	TYPICAL MAXIMUM CLOCK FREQUENCY	TYPICAL POWER DISSIPATION
'164	36 MHz	21 mW per bit
'L164	18 MHz	11 mW per bit
'LS164	36 MHz	10 mW per bit

SN54164, SN54LS164 . . . J OR W PACKAGE
SN54L164 . . . J PACKAGE
SN74164 . . . J OR N PACKAGE
SN74LS164 . . . D, J OR N PACKAGE
(TOP VIEW)



SN54LS164 . . . FK PACKAGE
SN74LS164 . . . FN PACKAGE
(TOP VIEW)



NC – No internal connection

description

These 8-bit shift registers feature gated serial inputs and an asynchronous clear. The gated serial inputs (A and B) permit complete control over incoming data as a low at either input inhibits entry of the new data and resets the first flip-flop to the low level at the next clock pulse. A high-level input enables the other input which will then determine the state of the first flip-flop. Data at the serial inputs may be changed while the clock is high or low, but only information meeting the setup-time requirements will be entered. Clocking occurs on the low-to-high-level transition of the clock input. All inputs are diode-clamped to minimize transmission-line effects.

The SN54164, SN54L164 and SN54LS164 are characterized for operation over the full military temperature range of – 55°C to 125°C. The SN74164 and SN74LS164 are characterized for operation from 0°C to 70°C

FUNCTION TABLE

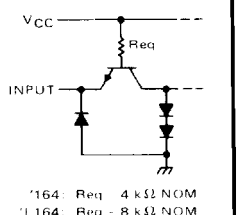
INPUTS				OUTPUTS			
CLEAR	CLOCK	A	B	Q_A	Q_B	...	Q_H
L	X	X	X	L	L		L
H	L	X	X	Q_{A0}	Q_{B0}		Q_{H0}
H	↑	H	H	H	Q_{An}		Q_{Gn}
H	↑	L	X	L	Q_{An}		Q_{Gn}
H	↑	X	L	L	Q_{An}		Q_{Gn}

H = high level (steady state), L = low level (steady state)
X = irrelevant (any input, including transitions)
↑ = transition from low to high level.
Q_{A0}, Q_{B0}, Q_{H0} = the level of Q_A, Q_B, or Q_H, respectively, before the indicated steady-state input conditions were established.
Q_{An}, Q_{Gn} = the level of Q_A or Q_G before the most-recent ↑ transition of the clock; indicates a one-bit shift.

schematics of inputs and outputs

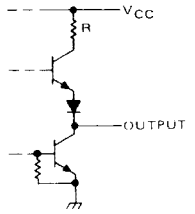
'164, 'L164

EQUIVALENT OF EACH INPUT



'164: Req = 4 kΩ NOM
'L164: Req = 8 kΩ NOM

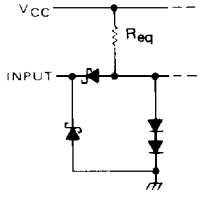
TYPICAL OF ALL OUTPUTS



'164: R = 200 Ω NOM
'L164: R = 400 Ω NOM

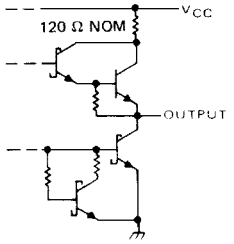
'LS164

EQUIVALENT OF EACH INPUT



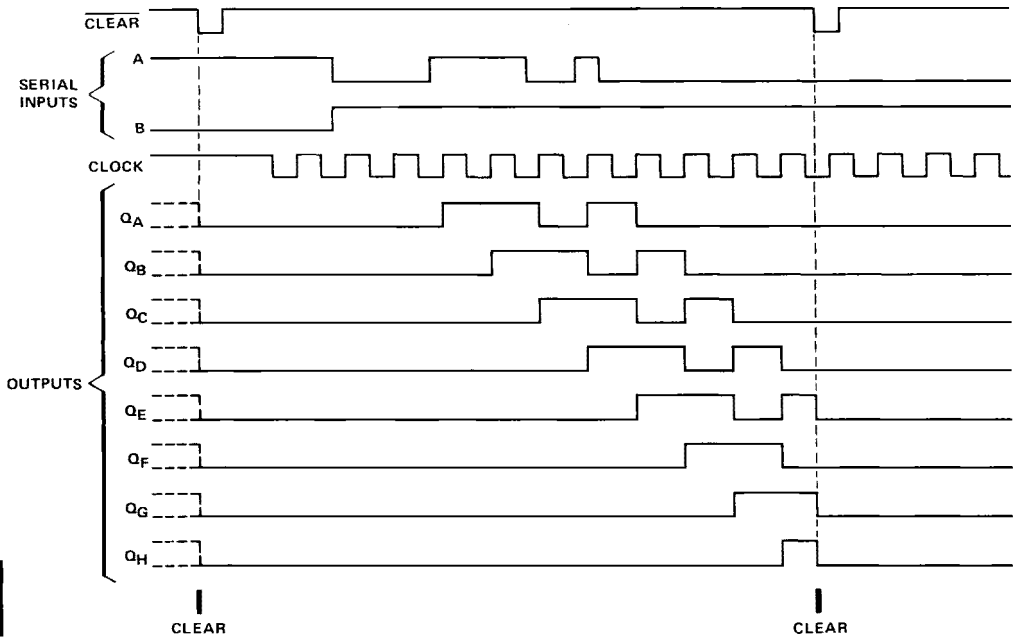
Clear, clock: 17 kΩ NOM
Serial in: 25 kΩ NOM

TYPICAL OF ALL OUTPUTS



3 TTL DEVICES

typical clear, shift, and clear sequences



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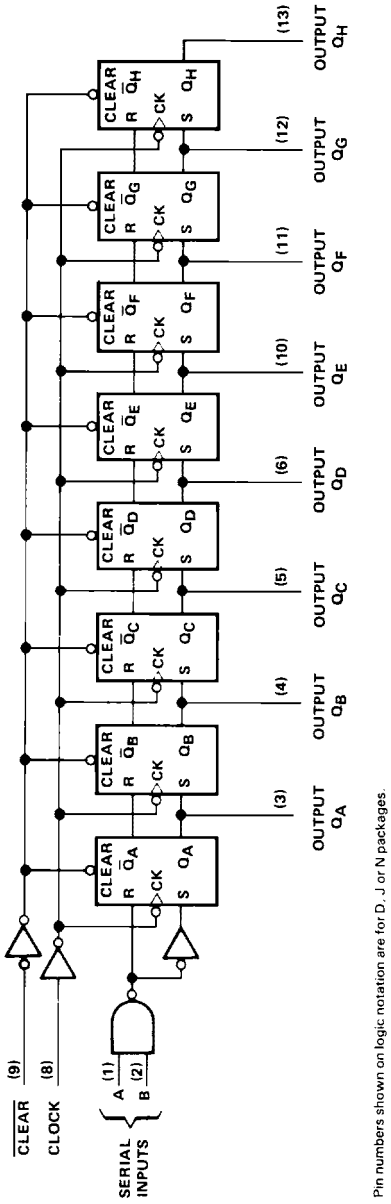
logic diagram



Pin numbers shown on logic notation are for D, J or N packages.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1) . . . . . 7 V
Input voltage . . . . . 5.5 V
Operating free-air temperature range: SN54164 . . . . . −55°C to 125°C
SN74164 . . . . . 0°C to 70°C
Storage temperature range . . . . . −65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

	SN54164			SN74164			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, V_{CC}	4.5	5	5.5	4.75	5	5.25	V
High-level output current, I_{OH}			−400			−400	μA
Low-level output current, I_{OL}			8			8	mA
Clock frequency, f_{clock}	0		25	0		25	MHz
Width of clock or clear input pulse, t_w	20			20			ns
Data setup time, t_{su} (see Figure 1)	15			15			ns
Data hold time, t_h (see Figure 1)	5			5			ns
Operating free-air temperature, T_A	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†		SN54164			SN74164			UNIT
				MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IH}	High-level input voltage			2			2			V
V_{IL}	Low-level input voltage					0.8			0.8	V
V_{IK}	Input clamp voltage	V_{CC} = MIN, I_I = −12 mA				−1.5			−1.5	V
V_{OH}	High-level output voltage	V_{CC} = MIN, V_{IH} = 2 V, V_{IL} = 0.8 V, I_{OH} = −400 μA		2.4	3.2		2.4	3.2		V
V_{OL}	Low-level output voltage	V_{CC} = MIN, V_{IH} = 2 V, V_{IL} = 0.8 V, I_{OL} = 8 mA			0.2	0.4		0.2	0.4	V
I_I	Input current at maximum input voltage	V_{CC} = MAX, V_I = 5.5 V,				1			1	mA
I_{IH}	High-level input current	V_{CC} = MAX, V_I = 2.4 V				40			40	μA
I_{IL}	Low-level input current	V_{CC} = MAX, V_I = 0.4 V				−1.6			−1.6	mA
I_{OS}	Short-circuit output current§	V_{CC} = MAX		−10		−27.5	−9		−27.5	mA
I_{CC}	Supply current	V_{CC} = MAX, See Note 2	$V_{I(clock)}$ = 0.4 V		30			30		mA
			$V_{I(clock)}$ = 2.4 V		37	54		37	54	

† For conditions shown at MIN or MAX, use the appropriate value specified under recommended operating conditions.
‡ All typical values are at V_{CC} = 5 V, T_A = 25°C.
§ Not more than two outputs should be shorted at a time.
NOTE 2: I_{CC} is measured with outputs open, serial inputs grounded, and a momentary ground, then 4.5 V, applied to clear.

switching characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
f_{max}	Maximum clock frequency	R_L = 800 Ω, See Figure 1	C_L = 15 pF	25	36		MHz
t_{PHL}	Propagation delay time, high-to-low-level Q outputs from clear input		C_L = 15 pF		24	36	ns
			C_L = 50 pF		28	42	
t_{PLH}	Propagation delay time, low-to-high-level Q outputs from clock input		C_L = 15 pF	8	17	27	ns
			C_L = 50 pF	10	20	30	
t_{PHL}	Propagation delay time, high-to-low-level Q outputs from the clock input		C_L = 15 pF	10	21	32	ns
			C_L = 50 pF	10	25	37	

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1) . . . . . 7 V
Input voltage . . . . . 5.5 V
Operating free-air temperature range: SN54L164 . . . . . −55°C to 125°C
Storage temperature range . . . . . −65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

		MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			V
V_{IL}	Low-level input voltage			0.8	V
I_{OH}	High-level output current			−0.2	mA
I_{OL}	Low-level output current			4	mA
f_{clock}	Clock frequency	0		12	MHz
t_w	Width of clock or clear input pulse	40			ns
t_{su}	Data setup time (See Figure 1)	30			ns
t_{th}	Data hold time (See Figure 1)	10			ns
T_A	Operating free-air temperature	−55		125	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS†	MIN	TYP‡	MAX	UNIT
V_{IK}	V_{CC} = MIN, I_I = −12 mA			−1.5	V
V_{OH}	V_{CC} = MIN, V_{IH} = 2 V, V_{IL} = 0.8 V, I_{OH} = −0.2 mA	2.4	3.2		V
V_{OL}	V_{CC} = MIN, V_{IH} = 2 V, V_{IL} = 0.8 V, I_{OL} = 4 mA		0.2	0.4	V
I_I	V_{CC} = MAX, V_I = 5.5 V			1	mA
I_{IH}	V_{CC} = MAX, V_I = 2.4 V			20	μA
I_{IL}	V_{CC} = MAX, V_I = 0.4 V			−0.8	mA
I_{OS}§	V_{CC} = MAX	−5		−20	mA
I_{CC}	V_{CC} = MAX, See Note 3		19	27	mA

† For conditions shown at MIN or MAX, use the appropriate value specified under recommended operating conditions.
‡ All typical values are at V_{CC} = 5 V, T_A = 25°C
§ Not more than two outputs should be shorted at a time.
NOTE 3: I_{CC} is measured with outputs open, serial inputs grounded, the clock input at 2.4 V, and a momentary ground, then 4.5 V, applied to clear.

switching characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
f_{max}	Maximum clock frequency	R_L = 800 Ω, See Figure 1	C_L = 15 pF	12	18		MHz
t_{PHL}	Propagation delay time, high-to-low-level Q outputs from clear input		C_L = 15 pF		48	72	ns
			C_L = 50 pF		56	84	
t_{PLH}	Propagation delay time, low-to-high-level Q outputs from clock input		C_L = 15 pF	8	34	54	ns
			C_L = 50 pF	10	20	60	
t_{PHL}	Propagation delay time, high-to-low-level Q outputs from the clock input		C_L = 15 pF	10	42	64	ns
			C_L = 50 pF	10	50	74	

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1) . . . . . 7 V
Input voltage . . . . . 7 V
Operating free-air temperature range: SN54LS164 . . . . . −55°C to 125°C
SN74LS164 . . . . . 0°C to 70°C
Storage temperature range . . . . . −65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

		SN54LS164			SN74LS164			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.7			0.8	V
I_{OH}	High-level output current			−0.4			−0.4	mA
I_{OL}	Low-level output current			4			8	mA
f_{clock}	Clock frequency	0		25	0		25	MHz
t_w	Width of clock or clear input pulse	20			20			ns
t_{su}	Data setup time (See Figure 1)	15			15			ns
t_{su}	Clear inactive setup time (See Figure 1)	15			15			ns
t_h	Data hold time (See Figure 1)	5			5			ns
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS†		SN54LS164			SN74LS164			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}	V_{CC} = MIN, I_I = −18 mA				−1.5			−1.5	V
V_{OH}	V_{CC} = MIN, V_{IH} = 2 V, V_{IL} = MAX, I_{OH} = −0.4 μA		2.5	3.5		2.7	3.5		V
V_{OL}	V_{CC} = MIN, V_{IH} = 2 V, V_{IL} = MAX	I_{OL} = 4 mA		0.25			0.25	0.4	V
		I_{OL} = 8 mA					0.35	0.5	
I_I	V_{CC} = MAX, V_I = 7 V				0.1			0.1	mA
I_{IH}	V_{CC} = MAX, V_I = 2.7 V				20			20	μA
I_{IL}	V_{CC} = MAX, V_I = 0.4 V				−0.4			−0.4	mA
I_{OS}	V_{CC} = MAX		−20		−100	−20		−100	mA
I_{CC}	V_{CC} = MAX, See Note 3			16	27		16	27	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
‡ All typical values are at V_{CC} = 5 V, T_A = 25°C.
§ Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second.
NOTE 3: I_{CC} is measured with outputs open, serial inputs grounded, the clock input at 2.4 V, and a momentary ground, then 4.5 V applied to clear.

switching characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
f_{max}	Maximum clock frequency	R_L = 2 kΩ, C_L = 15 pF, See Figure 1	25	36		MHz
t_{PHL}	Propagation delay time, high-to-low-level Q outputs from clear input			24	36	ns
t_{PLH}	Propagation delay time, low-to-high-level Q outputs from clock input			17	27	ns
t_{PHL}	Propagation delay time, high-to-low-level Q outputs from clock input			21	32	ns

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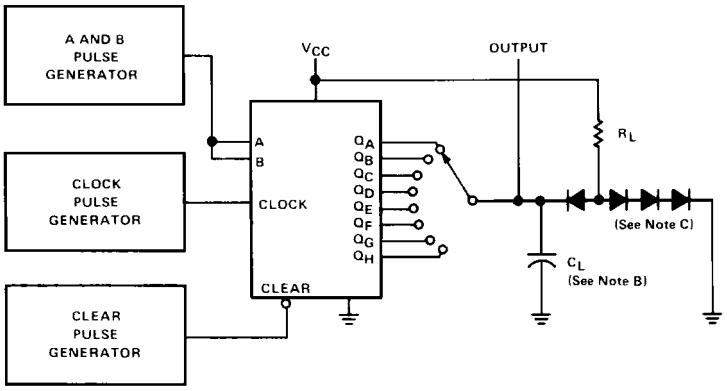
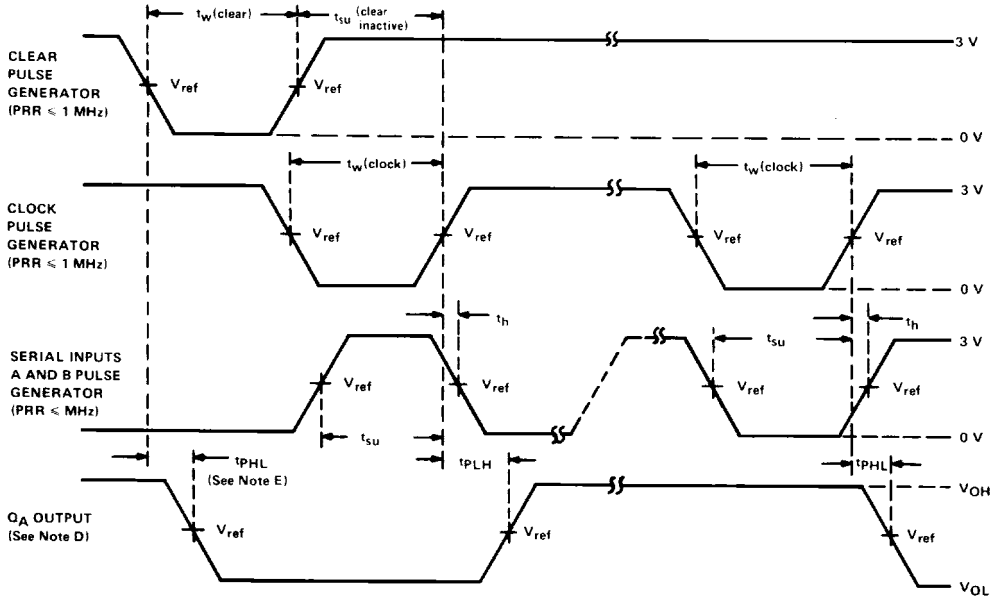
PARAMETER MEASUREMENT INFORMATION



TEST CIRCUIT



VOLTAGE WAVEFORMS

NOTES: A. The pulse generators have the following characteristics: duty cycle ≤ 50%, $Z_{out} \approx 50\ \Omega$, for '164 and 'L164, $t_r \leq 10$ ns, $t_f \leq 10$ ns, and for 'LS164, $t_r \leq 15$ ns, $t_f \leq 6$ ns.
B. C_L includes probe and jig capacitance.
C. All diodes are 1N3064 or equivalent.
D. Q_A output is illustrated. Relationship of serial input A and B data to other Q outputs is illustrated in the typical shift sequence.
E. Outputs are set to the high level prior to the measurement of t_{PHL} from the clear input.
F. For '164 and 'L164, $V_{ref} = 1.5$ V; for 'LS164, $V_{ref} = 1.3$ V.

FIGURE 1–SWITCHING TIMES